## Search Notes



	Applicant(s)/Patent under Reexamination
10/686,782	SONTHEIMER ET AL.
Examiner	Art Unit

Shin-Lin Chen

SEARCHED					
Class	Subclass	Date	Examiner		
514	2	9/4/2009	SLC		
435	7.1				
	7.23	9/4/2009	SLC		
530	350	9/4/2009	SLC		
		i			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
514	2	9/4/2009	SLC	
435	7.1			
435	7.23	9/4/2009	SLC	
	J interference arch.	9/4/2009	SLC	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
Updated, inventor name search.	9/4/2009	SLC		